

L Number	Hits	Search Text	DB	Time stamp
1	6	(sample adj manufacturing) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:45
2	36	(sample adj manufacturing) and stage	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:38
3	3	((sample adj manufacturing) and stage) and (sample adj stage)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:37
4	133	sample adj manufacturing	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:38
5	1153	sample adj manufactur\$3	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:39
6	1153	(sample adj manufactur\$3) and sample	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:42
7	5	(sample adj manufactur\$3) and (sample adj stage)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:42
8	373	((sample adj manufactur\$3) and sample) and stage	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:43
10	5	((((sample adj manufactur\$3) and sample) and stage) and diagonally	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:43
9	15	((((sample adj manufactur\$3) and sample) and stage) and diagonal	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:44
11	0	(((((sample adj manufactur\$3) and sample) and stage) and diagonal) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:46
12	0	(((((sample adj manufactur\$3) and sample) and stage) and diagonally) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:57
13	1	(((((sample adj manufactur\$3) and sample) and stage) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:57

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-	1153	(sample adj manufactur\$3) and sample	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:42
-	5	(sample adj manufactur\$3) and (sample adj stage)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:42
-	373	((sample adj manufactur\$3) and sample) and stage	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 16:21
-	5	((sample adj manufactur\$3) and sample) and stage) and diagonally	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:43
-	15	((sample adj manufactur\$3) and sample) and stage) and diagonal	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:44
-	0	((sample adj manufactur\$3) and sample) and stage) and diagonal) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:46
-	0	((sample adj manufactur\$3) and sample) and stage) and diagonally) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 15:57
-	1	((sample adj manufactur\$3) and sample) and stage) and ((focused adj ion adj beam) or FIB)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 16:20
-	2	((sample adj manufactur\$3) and sample) and stage) and (side adj entry)	USPAT; US-PGPUB; EPO; JPO; IBM_TDB	2004/06/08 16:21